

## SPECIFICATION FOR LCD MODULE

MODULE NO: YB-YG240320C10A-N-C1

Doc.Version:00

Customer Approv	val:		
☐ Accept			☐ Reject
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☐ APPROVAL	FOR SPECIFICATIONS	ONLY	
■ APPROVAI	FOR SPECIFICATIONS	AND SAMPLE	
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## 1. Revision History

Sample Version	DOC. Version	DATE	DESCRIPTION		CHANGED BY
C1	00	2016-9-29	Full Spec	First issue	Rannie/Jimmy
			1		



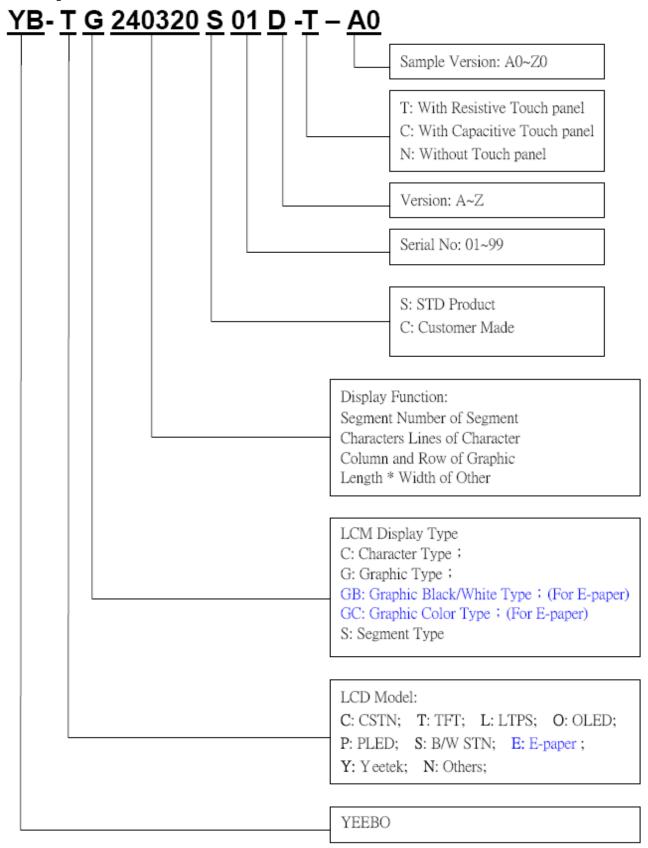
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#### 3. Module Numbering System:

(Example)



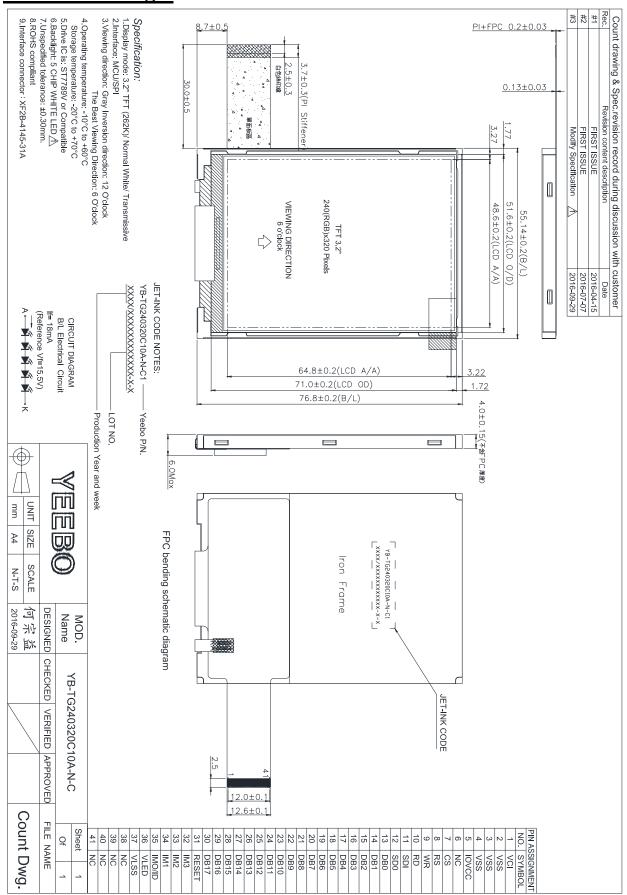


## 4. General Specification:

ITEM	CONTENTS			
Module Size	55.14(W) * 76.80(H) *4.0(T) mm			
Display Size(Diagonal)	3.2 inch			
Display Format	240(RGB)* 320 Pixels			
Active Area	48.60(W) * 64.80(H) mm			
Pixel Pitch	0.2025* 0.2025mm			
LCD Type	TFT (262K)/ Transmissive / NW			
The Best View Angle	6 O'clock			
View Angle (Gray Inversion)	12 O'clock			
Controller IC	ST7789V			
Weight	24.6g			



### 5. LCM drawing:





### **6. Electrical Characteristics**

### **6-1 Absolute Maximum Ratings**

(Ta=25°C VSS=0V)

Item	Symbol	Min.	Туре	Max.	Unit	Remark
Supply Voltage for Logic circuit	VCC	-0.3	1	4.6	Volt	ı
Operating Temperature	Topr	-20	-	+70	$^{\circ}$ C	-
Storage Temperature	Tstg	-30	-	+80	$^{\circ}\mathbb{C}$	-

Note1: Absolute maximum rating is the limit value beyond which the IC maybe broken. They do not assure operations.

### **6-2 Operating Conditions**

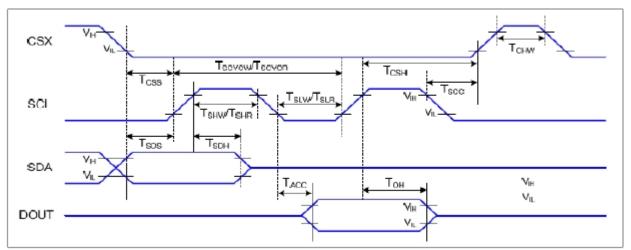
(Ta=25°C)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Power Supply voltage	VCC	-	2.5	2.8	3.3	Volt
Normal mode Current consumption	Icc	-	-	8	12	mA
TFT Gate ON Voltage	VGH	-	12.2	-	14.97	V
TFT Gate OFF Voltage	VGL	-	-12.5	-	-7.16	V

Module P/N: YB-YG240320C10A-N-C1 Doc.Version:00



## **6-3 Timing Characteristics**Serial Interface Characteristics (3-line serial)



**3-line serial Interface Timing Characteristics** 

VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=-30 to 70 ℃

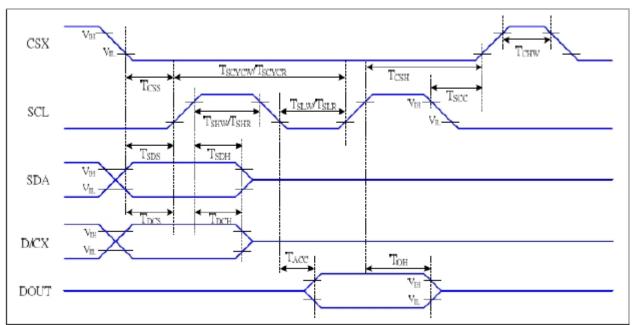
Signal	Symbol	Parameter	Min	Max	Unit	Description
	T <sub>CSS</sub>	Chip select setup time (write)	15		ns	
T <sub>CSH</sub>		Chip select hold time (write)	15		ns	
CSX	T <sub>CSS</sub>	Chip select setup time (read)	60		ns	
	Tscc	Chip select hold time (read)	65		ns	
	T <sub>CHW</sub>	Chip select "H" pulse width	40		ns	
	T <sub>SCYCW</sub>	Serial clock cycle (Write)	66		ns	
	T <sub>SHW</sub>	SCL "H" pulse width (Write)	15		ns	
SCL	T <sub>SLW</sub>	SCL "L" pulse width (Write)	15		ns	
SCL	T <sub>SCYCR</sub>	Serial clock cycle (Read)	150		ns	
	T <sub>SHR</sub>	SCL "H" pulse width (Read)	60		ns	
	T <sub>SLR</sub>	SCL "L" pulse width (Read)	60		ns	
SDA	T <sub>SDS</sub>	Data setup time	10		ns	
(DIN)	T <sub>SDH</sub>	Data hold time	10		ns	
DOUT	T <sub>ACC</sub>	Access time	10	50	ns	For maximum CL=30pF
DOUT	Тон	Output disable time	15	50	ns	For minimum CL=8pF

**3-line serial Interface Characteristics** 

Note: The rising time and falling time (Tr, Tf) of input signal are specified at 15 ns or less. Logic high and low levels are specified as 30% and 70% of VDDI for Input signals.



#### **Serial Interface Characteristics (4-line serial)**



**4-line serial Interface Timing Characteristics** 

VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=-30 to 70 ℃

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
	T <sub>CSS</sub>	Chip select setup time (write)	15		ns	
	T <sub>CSH</sub>	Chip select hold time (write)	15		ns	
CSX	T <sub>CSS</sub>	Chip select setup time (read)	60		ns	
	T <sub>scc</sub>	Chip select hold time (read)	65		ns	
	T <sub>CHW</sub>	Chip select "H" pulse width	40		ns	
	T <sub>scycw</sub>	Serial clock cycle (Write)	66		ns	write command 9 data
	T <sub>SHW</sub>	SCL "H" pulse width (Write)	15		ns	-write command & data
T <sub>SLW</sub>		SCL "L" pulse width (Write)	15		ns	ram
SCL	T <sub>SCYCR</sub>	Serial clock cycle (Read)	150		ns	-read command & data
	T <sub>SHR</sub>	SCL "H" pulse width (Read)	60		ns	ram
	T <sub>SLR</sub>	SCL "L" pulse width (Read)	60		ns	Idili
D/CX	T <sub>DCS</sub>	D/CX setup time	10		ns	
DICX	T <sub>DCH</sub>	D/CX hold time	10		ns	
SDA	T <sub>SDS</sub>	Data setup time	10		ns	
(DIN)	T <sub>SDH</sub>	Data hold time	10		ns	
DOUT	T <sub>ACC</sub>	Access time	10	50	ns	For maximum CL=30pF
וטטט	Тон	Output disable time	15	50	ns	For minimum CL=8pF

**4-line serial Interface Characteristics** 

Note: The rising time and falling time (Tr, Tf) of input signal are specified at 15 ns or less. Logic high and low levels are specified as 30% and 70% of VDDI for Input signals.



### 7. Optical Characteristics:

Item	tom Cymbol		Conditions	Specifications			Unit	Note
Item		Symbol	Conditions	Min	Тур	Max	Unit	Note
Transmitt	ance	T(%)	_		18	_	_	_
(Without	POL)	1(/0)		-	10	-	-	-
Contrast	Ratio	CR	⊖=0 Normal Viewing Angle	400	500	-		(1) (2)
Response	Time	TR+TF	_	-	16	32	ms	(1)(3)
	Hor	Өх+		-	70	-		
Viewing	ПОІ	Өх-	CR≧10	-	70	-	deg.	
angle	Ver	Өу+	CK=10	-	70	-	ueg.	-
	V CI	Өу-		-	60	-		

#### **Measuring Condition**

Measuring surrounding: dark room
 Ambient temperature: 25±2°C

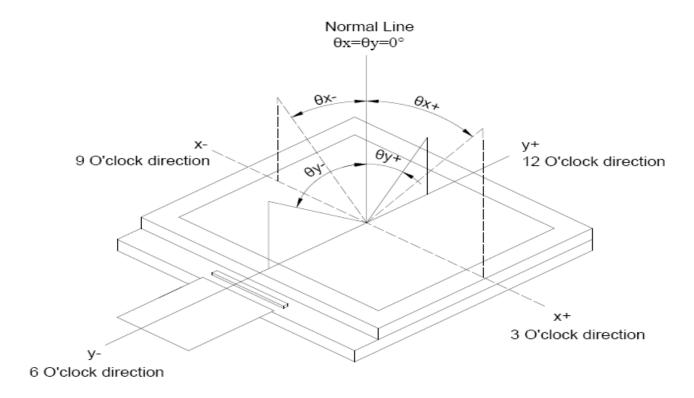
3. 30 min. Warm-up time.

### Color of CIE Coordinate:

Item	ltem		Condition	Min.	Тур.	Max.
	Red	х	$\theta = \phi = 0^{\circ}$	0.576	0.626	0.676
	rtcu	у	Backlight	0.284	0.334	0.384
Chromaticity	Green	х	Color	0.227	0.277	0.327
Coordinates	Green	у	Degree	0.499	0.549	0.599
(Transmissive)	Blue	Х	X=0.28 Y=0.28	0.092	0.142	0.192
(Transmissive)	Dide	у		0.072	0.122	0.172
	White -	Х		0.253	0.303	0.353
		у		0.275	0.325	0.375



#### Note (1) Definition of Viewing Angle:

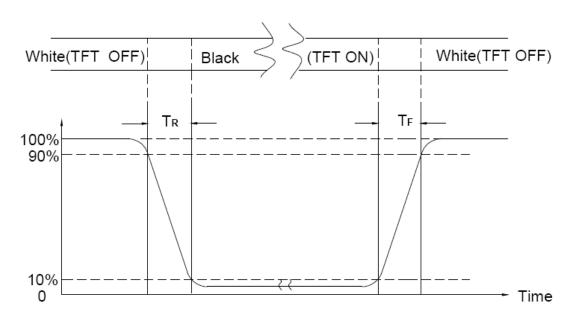


Note (2) Definition of Contrast Ratio(CR): measured at the center point of panel

Contrast ratio (CR)= Photo detector output when LCD is at "White" state

Photo detector output when LCD is at "Black

Note (3) Definition of Response Time: Sum of TR and TF





## **8. Interface Pin Assignment:**

Pin NO.	Symbol	Level	Function		
1	VCI	Н	Power supply		
2	VSS	L	Ground		
3	VSS	L	Ground		
4	VSS	L	Ground		
5	IOVCC	Н	Power supply		
6	NC	/	Not connected		
7	CS	H/L	Chip select input pin		
8	RS	H/L	A register select signal		
9	WR	H/L	Write enable clock input pin		
10	RD	H/L	Read enable clock input pin		
11	SDI	H/L	SPI interface Intput pin		
12	SDO	H/L	SPI interface output pin		
13—30	DB0-DB17	H/L	Data Bus D0-D17		
31	RESET	H/L	Hardware reset pin		
32	IM3	H/L	The MCU interface mode select.		
33	IM2	H/L	The MCU interface mode select.		
34	IM1	H/L	The MCU interface mode select.		
35	IM0	H/L	The MCU interface mode select.		
36	A	Н	Backlight+		
37	K	L	Backlight-		
38	NC	/	Not connected		
39	NC	/	Not connected		
40	NC	/	Not connected		
41	NC	/	Not connected		



#### 9. Backlight:

- 1. Standard Lamp Styles (Edge Lighting Type):
  The LED chips are distributed over the edge light area of the illumination unit, which gives the less power consumption:
- 2. The Main Advantages of the LED Backlight are as following:
  - 2.1 The brightness of the backlight can simply be adjusted. By a resistor or a potentiometer.

3.	Data About	LED	Backlight:
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(Ta=25°C)

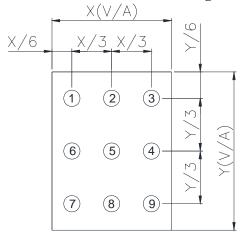
. Data 100tt EED Backinght.						. = ,	
PARAMETER	Sym.	Min.	Тур.	Max.	Unit	Test Condition	Note
Supply Current	Ι	-	18	1	mA	-	
Supply Voltage	V	14.5	-	16.5	V	If=18mA	
Reverse Current	IR	-	-	20	uA	Vr=5.0V	
Luminous Intensity for LCM	IV	400	500	1	Cd/m2	2	2
Uniformity for LCM	-	80	-	-	%	If=18mA	3
Life Time	-	20000	50000	-	Hr.		4
Color White							

#### NOTE:

- 1. Backlight Only
- 2. Average Luminous Intensity of P1-P5
- 3. Uniformity = Min/Max \* 100%
- 4. LED life time defined as follows: The final brightness is at 80% of original brightness At Ta=25°C and If=20mA. The LED lifetime could be decreased If is lager than 18mA. The LED can work about 50000 hours.

#### **Measured Method: (X\*Y: Light Area)**

#### **Internal Circuit Diagram**





#### (Effective spatial Distribution)

Hole Diameter ø10 mm; 1 to 5 per Position Measured Luminous



# 10. Standard Specification for Reliability: 10–1. Standard Specifications for Reliability of LCD Module

No	Item	Description
01	High temperature operation	The sample should be allowed to stand at 70°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
02	Low temperature operation	The sample should be allowed to stand at -20°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
03	High temperature storage	The sample should be allowed to stand at 80°C for 240 hours under no-load condition, and then returning it to normal temperature condition, and allowing it stand for 2 hours.
04	Low temperature storage	The sample should be allowed to stand at -30°C for 240 hours under no-load condition, then returning it to normal temperature condition, and allowing it stand for 2 hours.
05	Moisture storage	The sample should be allowed to stand at 60°C,90%RH MAX for 240 hours under no-load condition, then taking it out and drying it at normal temperature for 2 hours.
06	Thermal shock storage	The sample should be allowed to stand the following 10 cycles: $-30^{\circ}$ C for 30 minutes $\rightarrow$ normal temperature for 5 minutes $\rightarrow$ +80°C for 30 minutes $\rightarrow$ normal temperature for 5 minutes, as one cycle.
07	Packing vibration	Frequency range: 10Hz ~ 55Hz Amplitude of vibration: 1.5mm X,Y,Z 2 hours for each direction.  Sweep time: 12 min
08	Packing drop test	According to ISTA 1A 2001.
09	Electrical Static	Air: $\pm 4KV$ 150pF/330 $\Omega$ 5 times
	Discharge	Contact: $\pm 2KV \ 150pF/330\Omega \ 5$ time

<sup>\*</sup>Sample size for each test item is 3~5pcs



#### 10 - 2. Testing Conditions and Inspection Criteria

For the final test the testing sample must be stored at room temperature for 24 hours, after the tests listed in Table 10-1, Standard specifications for Reliability have been executed in order to ensure stability.

No	Item	Test Model	In section Criteria
01	Current Consumption	Refer To Specification	The current consumption should conform to the product specification.
02	Contrast	Refer To Specification	After the tests have been executed, the contrast must be larger than half of its initial value prior to the tests.
03	Appearance	Visual inspection	Defect free.

#### 10-3. MTBF

MTBF	Functions, performance, appearance, etc. shall be free from remarkable deterioration within 50,000 hours under ordinary operating and storage conditions room temperature ( $25\pm5^{\circ}$ C), normal humidity ( $50\pm10\%$ RH), and in area not exposed to direct sun light.
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#### 11. Specification of Quality Assurance:

#### 11-1. Purpose

This standard for Quality Assurance should affirm the quality of LCD module products to supply to purchaser by YEEBO CORPORATION (Supplier).

#### 11-2. Standard for Quality Test

a. Inspection:

Before delivering, the supplier should take the following tests, and affirm the quality of product.

b. Electro-Optical Characteristics:

According to the individual specification to test the product.

c. Test of Appearance Characteristics:

According to the individual specification to test the product.

d. Test of Reliability Characteristics:

According to the definition of reliability on the specification for testing products.

e. Delivery Test:

Before delivering, the supplier should take the delivery test.

- (i) Test method: According to **ISO2859-1.** General Inspection Level 

  ☐ take a single time.
- (ii) The defects classify of AQL as following:

Major defect: AQL = 0.65 Minor defect: AQL = 2.5 Total defects: AQL = 2.5

- 11-3. Non- conforming Analysis & Deal With Manners
  - a. Non-conforming Analysis:
  - (i) Purchaser should supply the detail data of non- conforming sample and the non-conforming.
  - (ii) After accepting the detail data from purchaser, the analysis of non- conforming should be finished in two weeks.
  - (iii) If supplier can not finish analysis on time, must announce purchaser before 3 days.
  - b. Disposition of non- conforming:
    - (i) If find any product defect of supplier during assembly time, supplier must change the good product for every defect after recognition.
    - (ii) Both supplier and customer should analyze the reason and discuss the disposition of non- conforming when the reason of nonconforming is not sure.
- 11-4. Agreement items

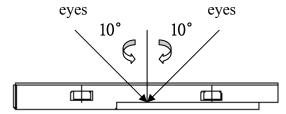
Both sides should discuss together when the following problems happen.

- a. There is any problem of standard of quality assurance, and both sides should think that must be modified.
- b. There is any argument item which does not record in the standard of quality assurance.
- c. Any other special problem.

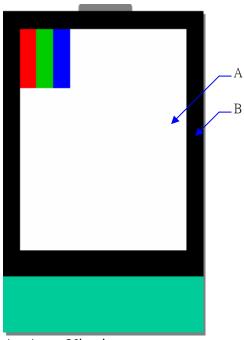


#### 11-5. Standard of The Product Appearance Test

- a. Manner of appearance test:
- (i) The test must be under  $20W \times 2$  or 40W fluorescent light, and the distance of view must be at  $30\pm5$ cm.
  - (ii) When test the model of transmissive product must add the reflective plate.
  - (iii)The test direction is base on around 10° of vertical line.
  - (iiii)Temperature: 25±5°C Humidity: 60±10%RH



(iv) Definition of area:



- A. Area: Viewing area.
- B. Area: Out of viewing area.

(Outside viewing area)

- b. Basic principle:
  - (i) It will accord to the AQL when the standard can not be described.
  - (ii) The sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
  - (iii) Must add new item on time when it is necessary.
  - c. Standard of inspection: (Unit: mm)



11-6. Inspection specification
Defect out of viewing area can be neglected.

NO	Item	Criterion				
01	Electrical Testing	1.1 Missing vertical, 1.2 Missing characte 1.3 Display malfunc 1.4 No function or n 1.5 Current consump 1.6 LCD viewing an 1.7 Mixed product ty 1.8 Flicker	er, dot or icon. tion. o display. otion exceeds gle defect.			0.65
02	Black or White spots or Bright spots or Color spots on LCD (Display only)	<ul><li>2.1 White and black</li><li>Five spots.</li><li>2.2 Densely spaced:</li></ul>	No more than	three spots within		2.5
03	LCD and Touch Panel black spots, white spots,		ensely spaced:	Size(mm) $Φ \le 0.10$ $0.10 < Φ \le 0.20$ $0.20 < Φ \le 0.25$ $0.25 < Φ \le 0.30$ 0.30 < Φ No more than two	Acceptable Q'ty Accept no dense  2 2 1 0 spots within 3mm.	2.5
	contamination (non – display)	3.2 Line type: (As for the state of the stat	bllowing draw  Length(mm) $L \leq 3.0$ $L \leq 2.5$	$\begin{array}{c} \text{Width(mm)} \\ \text{W} \leq 0.02 \\ \hline 0.02 < \text{W} \leq 0.05 \\ 0.03 < \text{W} \leq 0.15 \\ \hline 0.15 < \text{W} \end{array}$	Acceptable Q'ty Accept no dense 2 Rejection o lines within 3mm.	2.5



NO	Item	Criterion			
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction	Size Φ(mm) $Φ \le 0.20$ $0.20 < Φ \le 0.50$ $0.50 < Φ \le 1.00$ $1.00 < Φ$ Total Q'ty	Acceptable Q'ty Accept no dense 3 2 0 3	2.5
05	Scratches	Follow NO.3 -2 Line Type.			
06	Chipped glass	Symbols:     x: Chip length	ckness a: LCD side ack between panels $x = x$ and $x $	length  length  1/8a  each chip  length  1/8a  1/8a	2.5



NO	Item	Criterion	AQL
		Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: LCD side length 7.2 Protrusion over terminal: 7.2.1 Chip on electrode pad:	
		y: Chip width x: Chip length z: Chip thickness	
		$y \le 0.5 \text{mm} \qquad x \le 1/8 \text{a} \qquad 0 < z \le t$	
07	Glass crack	Non-conductive portion:	2.5
		y: Chip width x: Chip length z: Chip thickness	
		$y \leq L \qquad x \leq 1/8a \qquad 0 < z \leq t$	
		<ul> <li> If there chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications.</li> <li> If the product will be heat sealed by the customer, the alignment mark must mot be damaged.</li> <li>7.2.3 Substrate protuberance and internal crack</li> <li>y: width x: length</li> <li>y ≤ 1/3L X ≤ a</li> </ul>	



NO	Item	Criterion	AQL
08	Cracked glass	The LCD with extensive crack is not acceptable.	2.5
09	Backlight elements	<ul> <li>9.1 Illumination source flickers when lit.</li> <li>9.2 Spots or scratches that appear when lit must be judged. Using LCD spot, lines and contamination standards.</li> <li>9.3 Backlight doesn't light or color is wrong.</li> </ul>	2.5 2.5 0.65
10	Bezel	Bezel must comply with product specifications.	2.5
11	PCB、COB	<ul> <li>11.1 COB seal may not have pinholes larger than 0.2mm or contamination.</li> <li>11.2 COB seal surface may not have pinholes through to the IC.</li> <li>11.3 The height of the COB should not exceed the height indicated in the assembly diagram.</li> <li>11.4 There may not be more than 2mm of sealant outside the seal area on PCB. And there should be no more than three places.</li> <li>11.5 Parts on PCB must be the same as on the production characteristic chart, There should be no wrong parts, missing parts or excess parts.</li> <li>11.6 The jumper on the PCB should conform to the product characteristic chart.</li> </ul>	2.5 2.5 2.5 2.5 0.65
12	FPC	12.1 FPC terminal damage $\leq$ 1/2 FPC terminal width and can not affect the function, we judge accept. 12.2 FPC alignment hole damage $\leq$ 1/2 alignment area and can not affect the function, we judge accept.	2.5
13	Soldering	<ul><li>13.1 No cold solder joints, missing solder connections, oxidation or icicle.</li><li>13.2 No short circuits in components on PCB or FPC.</li></ul>	2.5 0.65



Symbols: x: Chip length k: Seal width t: Touch Panel Total thickness a: LCD side length L: Electrode pad length 14.1 General glass chip: 14.1.1 Chip on panel surface and crack between panels:    Z Chip thickness   y: Chip width   x: Chip length   Z≤t   viewing area   x≤1/8a	NO	Item		Criterion		AQL
Touch Panel Chipped glass $Z \le t$ $Z \ge t$ $Z $	INU	nem	x: Chip length k: Seal width length L: Electrode pad length 14.1 General glass cl	y: Chip width z: t: Touch Panel Total t gth hip:	chickness a: LCD s	
glass  ⊙ Unit: mm  ⊙ If there are 2 or more chips, x is the total length of each chip  14.1.2 Corner crack:  z: Chip thickness  y: Chip width  ≤ 1/2 k and not over		Touch Panel		$\leq 1/2$ k and not over		
$\leq 1/2$ k and not over	14	Chipped	⊙ If there are 2 or m		length of each chip	2.5
			-	$\leq 1/2$ k and not over		



NO	Item	Criterion	AQL
15	Touch Panel(Fish eye, dent and bubble on film)		2.5
16	Touch Panel Newton ring	Newton ring dimension $\leq 1/2$ touch panel area and not affect font and line distortion( $\leq 2.5\%$ ), it is acceptable.	2.5
17	Touch Panel Linearity	Less than 2.5% is acceptable.	2.5
18	LCD Ripple	Touch the touch panel, can not see the LCD ripple. Pen: R 1.0mm silicon rubber. Operation Force: 80g	2.5
19	General appearance	<ul> <li>19.1 Pin type must match type in specification sheet.</li> <li>19.2 LCD pin loose or missing pins.</li> <li>19.3 Product packaging must the same as specified on packaging specification sheet.</li> <li>19.4 Product dimension and structure must conform to product specification sheet.</li> </ul>	0.65 0.65 0.65 0.65



#### 12. Handling Precaution:

#### 13-1 Handling of LCM

- Don't give external shock.
- Don't apply excessive force on the surface.
- Liquid in LCD is hazardous substance. Must not lick and swallow. when the liquid is attach to your hand, skin, cloth etc. Wash it out thoroughly and immediately.
- Don't operate it above the absolute maximum rating.
- Don't disassemble the LCM.
- The operators should be grounded whenever he/she comes into contact with the module. Never touch any of the conductive parts such as the LSI pads, the copper leads on the PCB and the interface terminals with any parts of the human body.
- The modules should be kept in antistatic bags or other containers resistant to static for storage.
- The module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

#### 13-2 Storage

- Store in an ambient temperature of 25±10°C, and in a relative humidity of 50±10%RH. Don't expose to sunlight or fluorescent light.
- Storage in a clean environment, free from dust, active gas, and solvent.
- Store in anti-static electricity container.
- Store without any physical load.

#### 13-3 Soldering

- Use only soldering irons with proper grounding and no leakage.
- Iron: No higher than 280±10°C and less than 3 sec during Hand soldering.
- Rewiring: no more than 2 times.

#### 13. Guarantee:

Our products meet requirements of the environment.

YEEBO ROHS requirement is based on European Union Directive 2011/65/EU (ROHS) Requirements and Update.

Module P/N: YB-YG240320C10A-N-C1 Doc.Version:00